

Test Report

No.: CANEC25019768425

Date: Aug 19, 2025

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Client Name: FOSHAN BLUE ROCKET ELECTRONICS CO.,LTD.

Client Address: NO.45 GUXIN ROAD,CHANCHENG DISTRICT,FOSHAN,GUANGDONG,P.R.C.

Sample Name: SOT-23 Semiconductor Device

Model No.: SOT-23

Client Ref. Information: SOT-323,SOD-123,SOD-323,SOD-123FL,SOT-89,SOP-8,SOP-7,ESOP-8,SOT-363,SOT-223,SOT23-6,SOT23-5,SOT23-3,SOT-523,SOD-523,TO-92,TO-92LM, TO-126F,TO-126,TO-277,TO-252,TO-251,TO-263,TO-262,TO-220,TO-220F,TO-220FL, TO-3P,TO-3PH,TO-3PL,TO-3PN,TSOT23-6,PDFN3×3,PDFN5×6, DFN8×8, PDFN3×2, HTSSOP-16,DFN0603,DFN1×1,DFN2×2,DFN3×3,DFN1006,DFN1.6×1.2,DFN3×2,DFN5×4,QFN3×3,QFN4×4,UMSB,SMC,GBU,SMA,GBJ,SMB ,MBS,SMBF ,KBP,SM AF ,MBF,ABS,ABF,UMB,KBP,DO-41,DBF , DBS , KBJ, GBP, TOLL-8L,DFN9*6,DFN5*6,QFN2*2

The above sample(s) and information were provided by the client.

SGS Job No.: GZP25-023039

Sample Receiving Date: Aug 12, 2025

Testing Period: Aug 12, 2025 ~ Aug 18, 2025

Test Requested: Select test(s) as requested by the client.

Test Method(s): Please refer to next page(s).

Test Result(s): Please refer to next page(s).

Test Requirement	Conclusion
Element(s)	See Results

Signed for and on behalf of
SGS-CSTC Standards Technical Services Co., Ltd. Guangzhou Branch

[Redacted Signature]

Allie Chen
Approved Signatory

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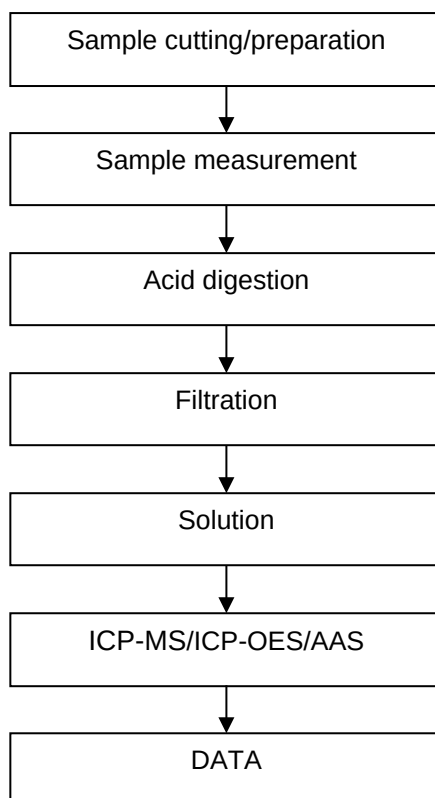
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Test Result(s):

Test Part Description:

SN ID	Sample No.	SGS Sample ID	Description
SN1	A1	CAN25-0197684-0001.C001	“SOT-23 Semiconductor Device”

Elements Testing Flow Chart



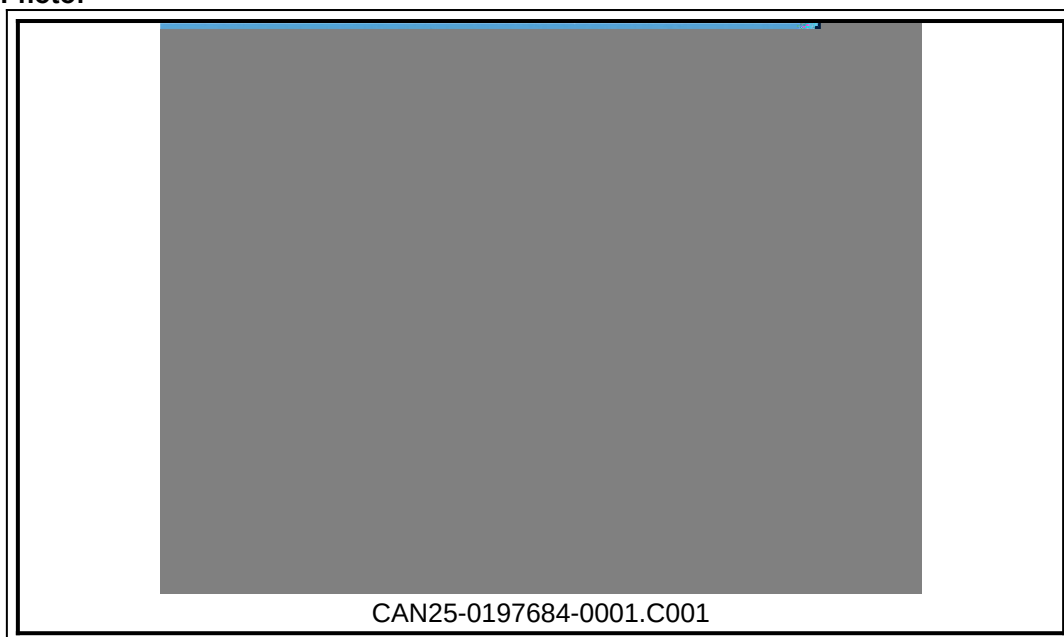
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Sample Photo:



SGS authenticate the photo on original report only

*** End of Report ***



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